SDLS172

- Three-State, 4 Bit. Cascadable, Parallel-In, Parallel-Out Registers
- 'LS395A Offers Three Times the Sink-Current Capability of 'LS395
- Low Power Dissipation . . . 75 mW Typical (Enabled)
- Applications: N-Bit Serial-To-Parallel Converter N-Bit Parallel-To-Serial Converter N-Bit Storage Register

description

These 4-bit registers feature parallel inputs, parallel outputs, and clock (CLK), serial (SER), load shift (LD/ \overline{SH}), output control (OC) and direct overriding clear (\overline{CLR}) inputs.

Shifting is accomplished when the load/shift control is low. Parallel loading is accomplished by applying the four bits of data and taking the load/shift control input high. The data is loaded into the associated flip-flops and appears at the outputs after the high-to-low transition of the clock input. During parallel loading, the entry of serial data is inhibited.

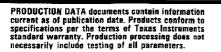
When the output control is low, the normal logic levels of the four outputs are available for driving the loads or bus lines. The outputs are disabled independently from the level of the clock by a high logic level at the output control input. The outputs then present a high impedance and neither load nor drive the bus line; however, sequential operation of the registers is not affected. During the high-impedance mode, the output at Ω_D' is still available for cascading.

logic symbol[†]

| | SRG4 | | |
|--------------|------------|-------------|------------------------|
| CLR (1) | R | | |
| oc (9) | EN4 | | |
| LD/SH (7) | M1 (LOAD) | | |
| | M2 (SHIFT) | | |
| CLK (10) | ≥C3/2- | | |
| SER (2) | 2,3D | | |
| A (3) | 1,3D | 4⊳⊽ | (15) Q _A |
| <u>в (4)</u> | 1,3D | | (14) OB |
| c (5) | 1,3D | 4 ⊳∇ | (13) QC |
| D <u>(6)</u> | 1,3D | 4⊳⊽ | (12) QD (11) QD' |

[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.





| SN54LS395A J OR W PACKAGE | |
|----------------------------|--|
| SN74LS395A D OR N PACKAGE | |
| (TOP VIEW) | |
| | |
| SER 2 15 0 _A | |
| | |
| $B \Box 4$ 13 $\Box Q_{C}$ | |

| в | Ц4 | 13 L C | |
|-------|------------|----------|---|
| C | | 12 QD | |
| D | 6 | 11 🗋 QD | |
| LD/SH | <u>[</u> 7 | 10 🗍 CLK | (|
| GND | Пe | 9 🗋 🔂 | |

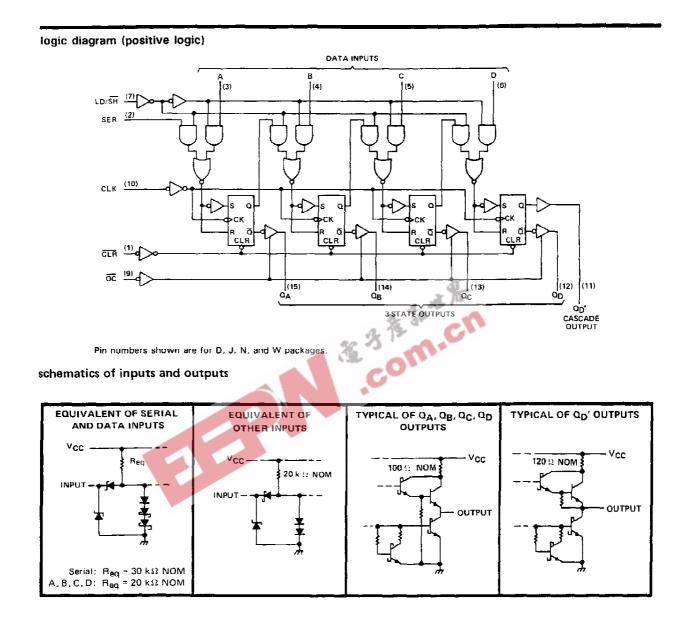




NC - No internal connection

SN54LS395A . . . J OR W PACKAGE

OCTOBER 1976 - REVISED MARCH 1988





| | | INPUTS | | | | | | 3-51 | ATE | OUTP | UTS | CASCAD |
|-----|-------|--------|-----|----|----|----|----|----------------|-----------------|-----------------|-----------------|-----------------|
| CLR | LD/SH | CLK | SER | PΔ | RA | LL | EL | | ~ | - | - | OUTPUT |
| | LUISH | LLA | JEH | A | 8 | С | D | Ω _A | σB | αc | ۵D | QD' |
| L | × | X | x | X | Х | Х | х | L | L | Ļ | L | L |
| н | н | н | х | x | х | х | х | QA0 | QB0 | Q _{C0} | Q _{D0} | 0 _{D0} |
| н | н | L | х | а | | с | | a | ь | c | d | d |
| н | L | н | x | X | х | х | х | QA0 | 080 | a _{co} | a _{D0} | Ω _{D0} |
| н | L | ↓ ↓ | н | X | х | х | х | н | QAn | QBn | a _{Cn} | |
| н | L | 1 | L | X | х | х | X | 1 | a _{An} | | | a _{Cn} |

FUNCTION TABLE

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

| Supply voltage, V _{CC} (see Note 1) | · · · · · · · · · · · · · · · · · · · |
|---|--|
| Input voltage | |
| Operating free-air temperature range: SN54LS395A . | |
| SN74LS395A | •••••••••••••••••••••••••••••••••••••• |
| Storage temperature range | -65°C to 150°C |
| NOTE 1: Voltage values are with respect to network ground terminal. | ~ O * |

C

recommended operating conditions

| | | SN54LS395A | | | SN74LS395A | | | |
|---|---|------------|-----|------|------------|-----|------|-----|
| | | MIN | NOM | МАХ | MIN | NOM | MAX | |
| Supply voltage, VCC | | 4.5 | 5 | 5.5 | 4.75 | 5 | 5.25 | v |
| High-level output current, IOH | Q _A , Q _B , Q _C , Q _D | | | -1 | 1 | | -2.6 | mA |
| ringinieven output current, TUH | OD. | | | -400 | | | -400 | μA |
| Low-level output current, IOL | QA, QB, QC, QD | | | 12 | | | 24 | mA |
| | QD, | | | 4 | _ | | 8 | mA |
| Clock frequency, fclock | | 0 | | 30 | 0 | | 30 | MHz |
| Width of clock pulse, tw(clock) | | 16 | | | 16 | | | ns |
| Setup time, high-level or low-level data, t _{su} | LD/SH | 40 | | | 40 | - | | 1 |
| | All other inputs | 20 | · | | 20 | | | ns |
| Hold time, high-level or low-level data, th | | 10 | | | 10 | | | ns |
| Operating free-air temperature, TA | | -55 | | 125 | 0 | | 70 | °c |



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| | | TEST CONDITIONS [†] | | | St | v54LS39 | 95A | S | | | |
|------------------|---|--|---------------------------------|--|------|---------|------|------|------|------|------|
| PARAMETÉR | | | | | MIN | түр‡ | MAX | MIN | TYP‡ | MAX | UNIT |
| VIH | High-level input voltage | | | | 2 | | | 2 | | | V |
| VIL | Low-level input voltage | | | | | | 0.7 | | | 0.8 | V |
| VIK | Input clamp voltage | V _{CC} = MIN, | l = -18 mA | | | | -1.5 | | | -1.5 | V |
| ∨он | High-level output voltage | Vcc = MIN, | VIH = 2 V, | 0 _A , 0 _B , 0 _C , 0 _D | 2.4 | 3.4 | | 2.4 | 3.1 | | v |
| | | VIL~VIL max, | VIL = VIL max, IOH = MAX | | 2.5 | 3.4 | | 2.7 | 3,4 | | V |
| | V _{CC} = MIN, | Q _A , Q _B , | 1 _{OL} = 12 mA | | 0.25 | 0.4 | | 0.25 | 0.4 | v | |
| | Low-level output voltage | VIL = VIL max, | a _c , a _D | I _{OL} = 24 mA | | | | | 0.35 | 0.5 |) Č |
| VOL | Cow-rever on that vortage | Vін = 2 V | 0 _{D'} | IOL = 4 mA | | 0.25 | 0.4 | | 0.25 | 0.4 | V |
| | | VIH - 2 V | | 10L = 8 mA | | | | | 0.35 | 0.5 | L. – |
| 1 | Off-state output current, | V _{CC} = MAX, V _{IH} = 2 | ViH ≈ 2 V, | Q _A , Q _B , | | 20 | | | | 20 | μА |
| ^I OZH | high-level voltage applied | V ₀ = 2.7 V | | a _c , a _D | | | 20 | | | | |
| 1 | Off-state output current, | V _{CC} = MAX, | V _{IH} = 2 V, | 0 _A , 0 _B , | | | -20 | | | -20 | μA |
| IOZL | low-level voltage applied | Vo = 0.4 V | | 0 _C , 0 _D | | 3 | -10 | | | | |
| ц | Input current at maximum input voltage | V _{CC} = MAX, | V = 7 V | - 4 | J. | 76 | 0.1 | | | 0.1 | mA |
| hΗ | High-level input current | V _{CC} ≖MAX, | Vi ≈ 2.7 V | A XE | | | 20 | | | 20 | μA |
| ΠL | Low-level input current | VCC = MAX, | VI = 0.4 V | 0 3 | | | -0.4 | | | -0.4 | mA |
| IOS | Short-circuit output current§ | VCC = MAX | | Q _A , Q _B , Q _C , Q _D | -30 | | -130 | -30 | | -130 | mA |
| | | | | QD | -20 | | -100 | -20 | | -100 | mA |
| 100 | Supply current | VCC = MAX, | See Note 2 | Condition A | | 22 | 34 | | 22 | 34 | mA |
| ICC | auppry current | VCC - WIMA | OFE LADIE Z | Condition B | | 21 | 31 | | 21 | 31 | |

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡]All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

NOTE 2: 1_{CC} is measured with the outputs open, the serial input and mode control at 4.5 V, and the data inputs grounded under the following conditions:

A. Output control at 4.5 V and a momentary 3 V, then ground, applied to clock input.

B. Output control and clock input grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25° C

| | PARAMETER | TEST CONDITIONS | MIN | ТҮР | MAX | UNIT |
|------------------|---|--|-----|-----|-----|------|
| fmax | Maximum clock frequency | See Note 3. | 30 | 45 | | MHz |
| tPHL | Propagation delay time, high-to-low-level output from clear | $\Box_A, Q_B, Q_C, Q_D $ outputs: | | 22 | 35 | ns |
| tPLH | Propagation delay time, low-to-high-level output | | | 15 | 30 | ns |
| tPHL | Propagation delay time, high-to-low-level output | $R_{L} = 667 \Omega, C_{L} = 45 pF$ | | 20 | 30 | ns |
| ^t PZH | Output enable time to high level | Ω _D 'output: R _I = 2 kΩ, C _I = 15 pF | | 15 | 25 | ns |
| tPZL | Output enable time to low level | | | 17 | 25 | ns |
| ^t PHZ | Output disable time from high level | C _L = 5 pF, | | 11 | 17 | ns |
| ^t PLZ | Output disable time from low level | See Note 3 | | 12 | 20 | ns |

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



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